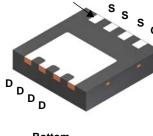
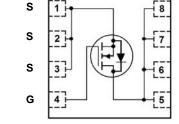


S п G 4 Bottom Top

Power 33

Pin 1







General Description

This N-Channel MOSFET is produced using Fairchild advanced PowerTrench® process that Semiconductor's incorporates Shielded Gate technology. This process has been optimized for the on-state resistance and yet maintain superior switching performance.

January 2014

Application

DC-DC Conversion

FDMC86340 N-Channel Shielded Gate Power Trench[®] MOSFET

80 V, 48 A, 6.5 mΩ

FAIRCHILD SEMICONDUCTOR

Features

- Shielded Gate MOSFET Technology
- Max $r_{DS(on)} = 6.5 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 14 \text{ A}$
- Max $r_{DS(on)} = 8.5 \text{ m}\Omega$ at $V_{GS} = 8 \text{ V}$, $I_D = 12 \text{ A}$
- High performance technology for extremely low r_{DS(on)}
- Termination is Lead-free
- RoHS Compliant



D

D

D

D

Units

V

V

А

mJ

W

°C

°C/W

200 216

80

±20

48

14

54

2.3

2.3

53

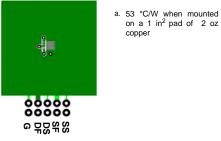
Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC86340	FDMC86340	Power33	13 "	12 mm	3000 units

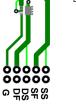
www.fairchildsemi.com

FDMC86340 N	
N-Channel	
Shielded G	
V-Channel Shielded Gate Power Trench[®] MOSFET	
Trench [®] N	D
MOSFET	

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	I _D = 250 μA, V _{GS} = 0 V	80			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C		46		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 64 V, V _{GS} = 0 V			1	μA
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			±100	nA
On Chara	cteristics					
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \ \mu A$	2.0	3.4	4.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C		-10		mV/°C
	•	V _{GS} = 10 V, I _D = 14 A		5.0	6.5	
	Static Drain to Source On Resistance	$V_{GS} = 8 \text{ V}, I_D = 12 \text{ A}$		6.0	8.5	mΩ
		V _{GS} = 10 V, I _D = 14 A, T _J = 125 °C		8.5	11	1
9 _{FS}	Forward Transconductance	V _{DD} = 10 V, I _D = 14 A		36		S
-	Characteristics			0775	0005	
Ciss	Input Capacitance	$V_{DS} = 40 V, V_{GS} = 0 V,$		2775	3885	pF
C _{oss}	Output Capacitance	-f = 1 MHz		468	655	pF
C _{rss}	Reverse Transfer Capacitance Gate Resistance		0.1	15 0.7	25 2.1	pF Ω
R _g			0.1	0.7	2.1	52
-	Characteristics					1
t _{d(on)}	Turn-On Delay Time	_		20	32	ns
t _r	Rise Time	$V_{DD} = 40 \text{ V}, \text{ I}_{D} = 14 \text{ A},$		7.9	16	ns
t _{d(off)}	Turn-Off Delay Time	V_{GS} = 10 V, R_{GEN} = 6 Ω		23	37	ns
t _f	Fall Time			5.1	10	ns
Q _{g(TOT)}	Total Gate Charge	$V_{GS} = 0 V \text{ to } 10 V$		38	53	nC
Q _{g(TOT)}	Total Gate Charge	$V_{GS} = 0 V \text{ to } 8 V$ $V_{DD} = 40 V$,		31	44	nC
Q _{gs}	Gate to Source Charge	I _D = 14 A		14		nC
Q _{gd}	Gate to Drain "Miller" Charge			8.0		nC
Q _{oss}	Output Charge	$V_{DD} = 40 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		42		nC
Drain-Soເ	urce Diode Characteristics			1	i	·
V _{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0 V, I_S = 14 A$ (Note 2)		0.8	1.3	V
-		$V_{GS} = 0 V, I_S = 1.9 A$ (Note 2)		0.7	1.2	V
t _{rr}	Reverse Recovery Time	I _F = 14 A, di/dt = 100 A/μs		41	66	ns
Q _{rr}	Reverse Recovery Charge	· · ·		25	40	nC

the user's board design.





b. 125 °C/W when mounted on a minimum pad of 2 oz copper

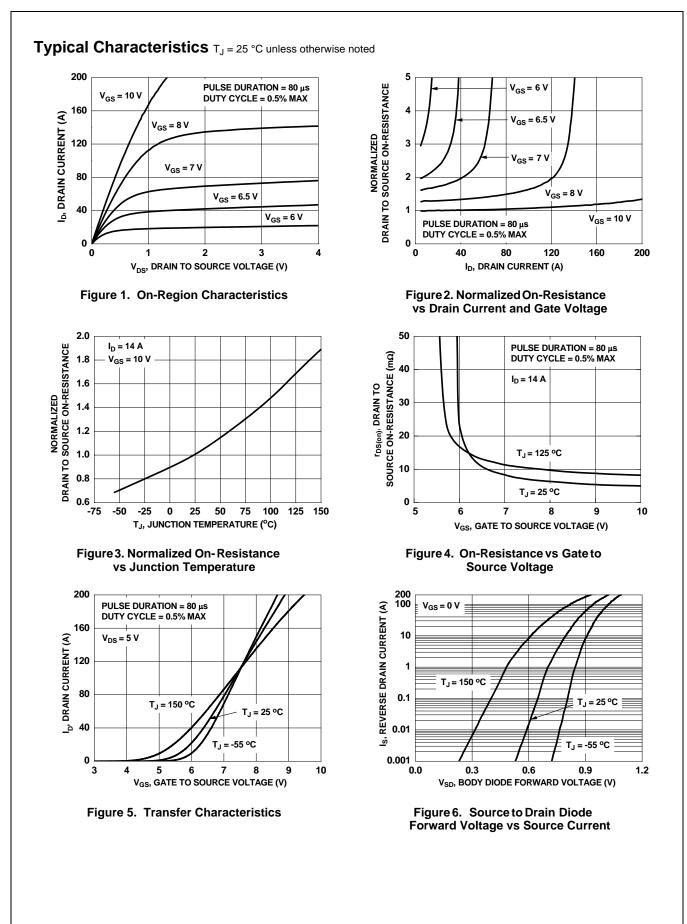
2. Pulse Test: Pulse Width < 300 $\mu s,$ Duty cycle < 2.0%.

3. E_{AS} of 216 mJ is based on starting T_J = 25 °C, L = 3 mH, I_{AS} = 12 A, V_{DD} = 80 V, V_{GS} = 10 V. 100% test at L = 0.1 mH, I_{AS} = 37 A.

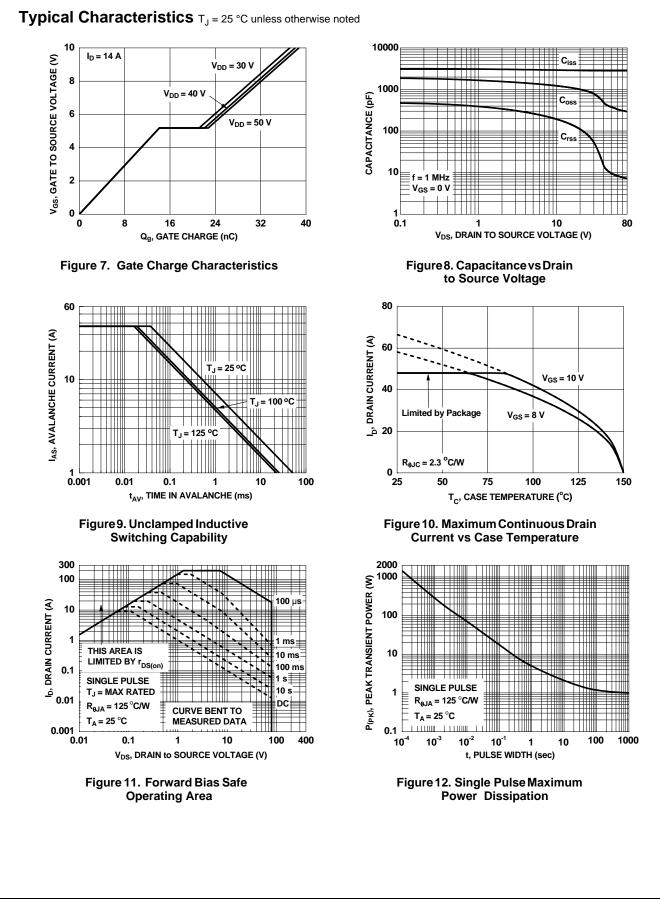
4. Pulsed Id limited by junction temperature, td<=100 μ S, please refer to SOA curve for more details.

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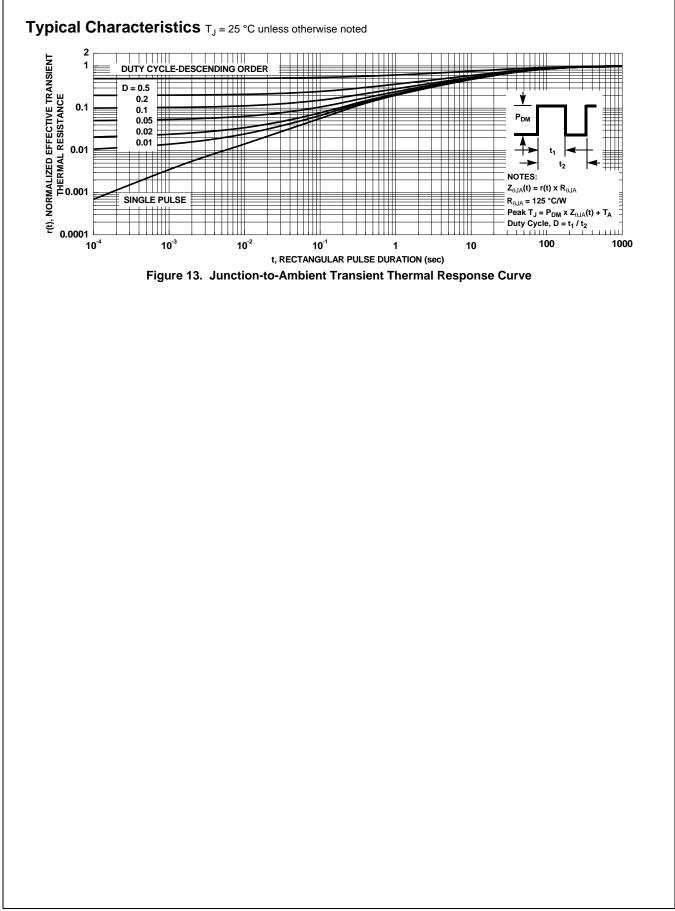


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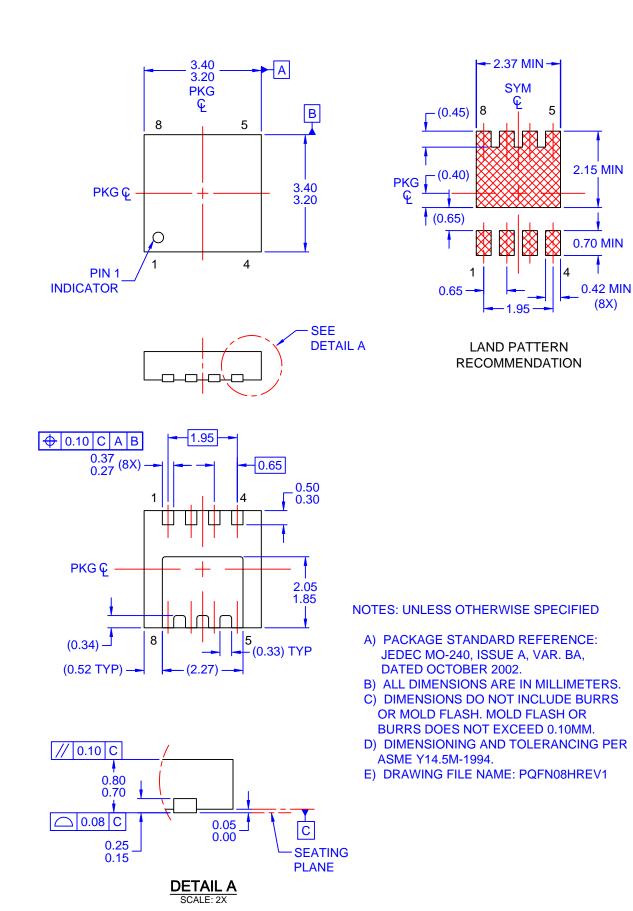


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FDMC86340 N-Channel Shielded Gate Power Trench[®] MOSFET



FDMC86340 N-Channel Shielded Gate Power Trench[®] MOSFET



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